

Fig. 1

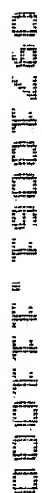
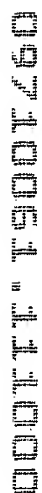
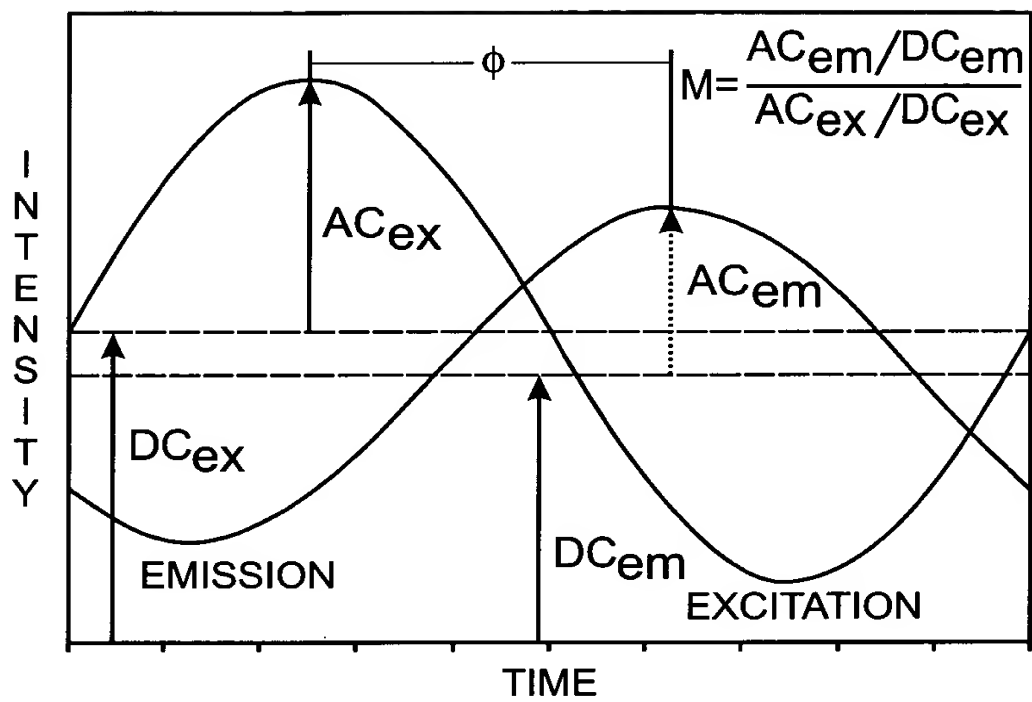
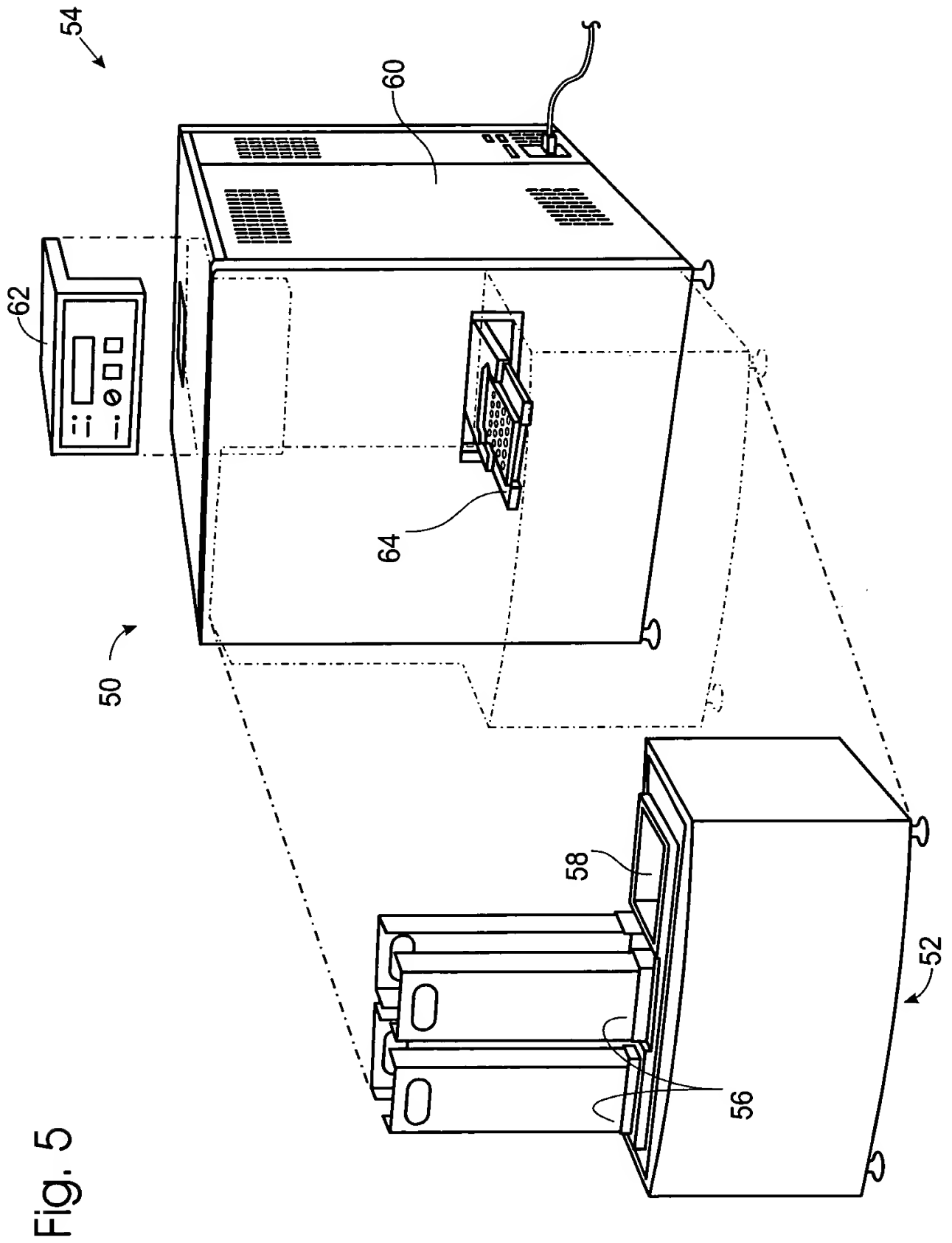
[illegible][illegible]

Fig. 4



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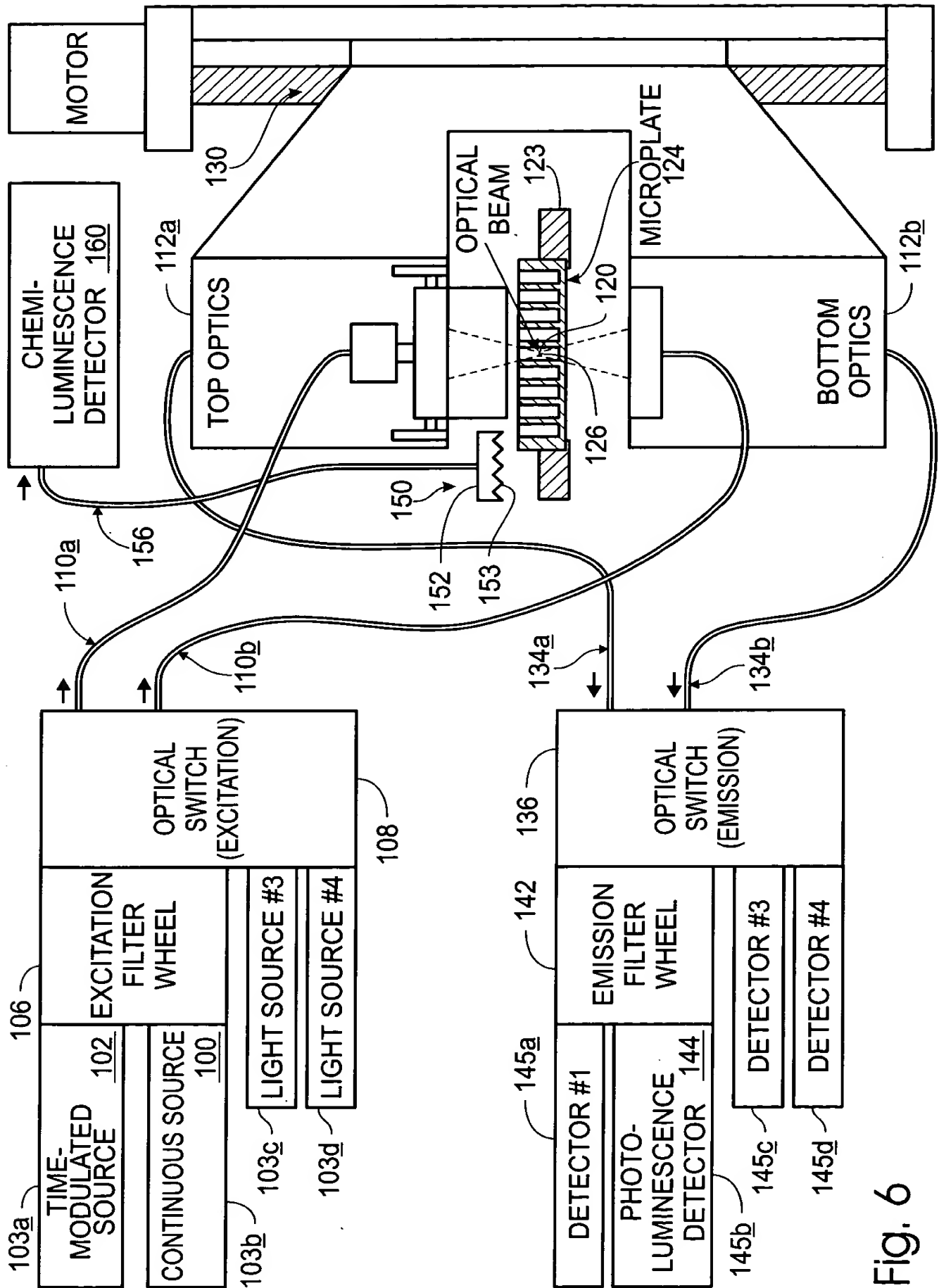


Fig. 6

Fig. 7

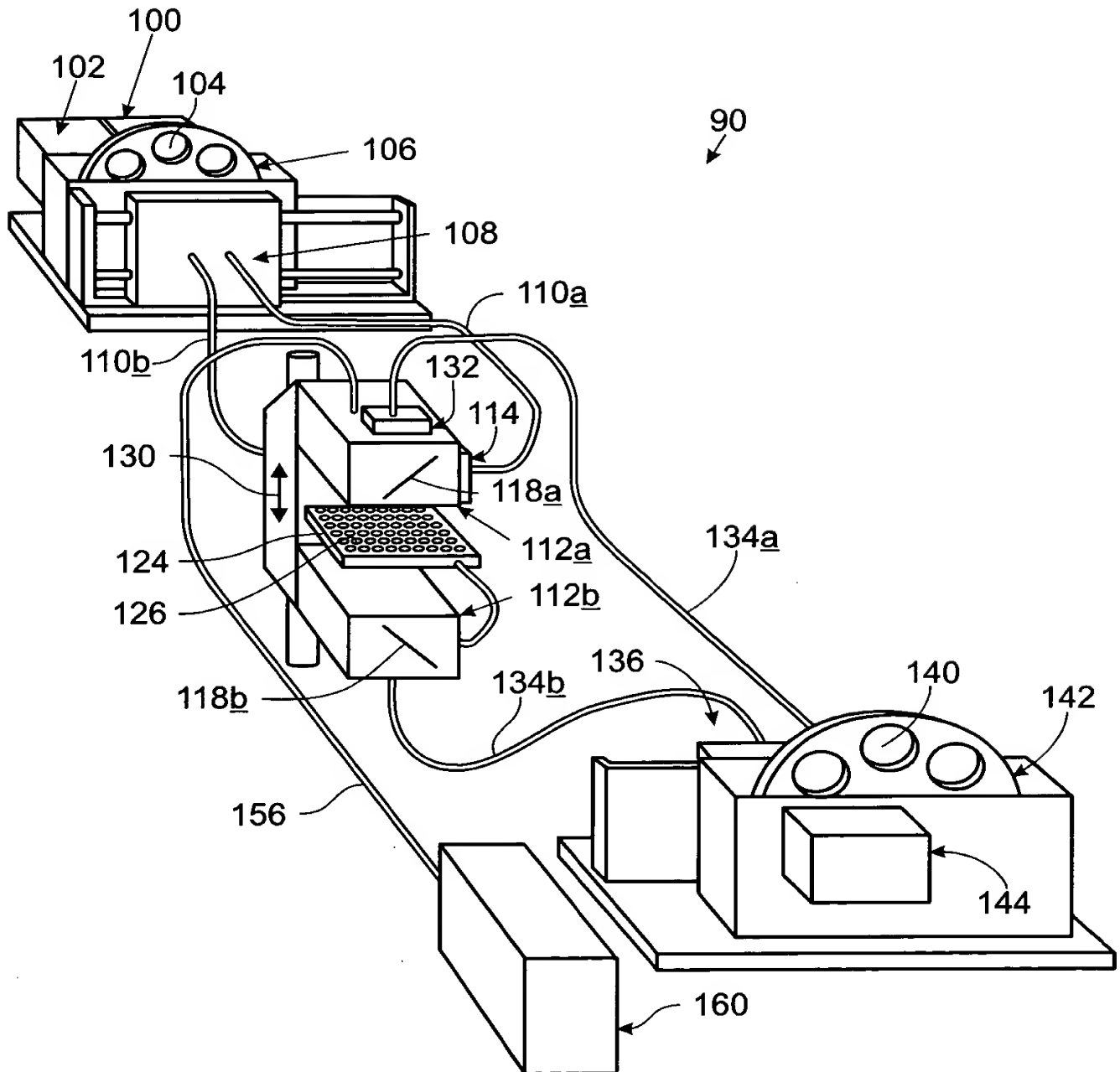


Diagram 9 illustrates a system for measuring the thickness of a thin film. A light source 120 emits a beam 126 through a substrate 154, reflecting off a thin film 158, and is detected by a detector 160. The thin film 158 is labeled with 'H' and 'O'.